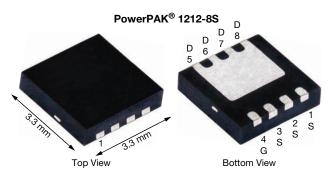
Vishay Siliconix

N-Channel 20 V (D-S) MOSFET

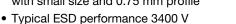


PRODUCT SUMMARY				
V _{DS} (V)	20			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 4.5 \text{ V}$	0.0039			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 3.7 \text{ V}$	0.0042			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 2.5 \text{ V}$	0.0058			
Q _g typ. (nC)	22.5			
I _D (A)	50 ^{f, g}			
Configuration	Single			

FEATURES

- TrenchFET® power MOSFET
- 100 % R_a and UIS tested





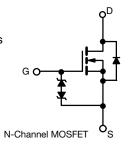
 Material categorization: for definitions of compliance please see www.vishav.com/doc?99912

RoHS COMPLIANT HALOGEN

FREE

APPLICATIONS

- Battery switch / load switch
- Power management for tablet PCs and mobile computing



ORDERING INFORMATION	
Package	PowerPAK 1212-8S
Lead (Pb)-free and halogen-free	SiS612EDNT-T1-GE3

PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V _{DS}	20	V	
Gate-source voltage		V _{GS}	± 12	V	
Continuous drain current (T _J = 150 °C)	T _C = 25 °C		50 ^g		
	T _C = 70 °C	I , F	50 g		
	T _A = 25 °C	† 'D	24.6 ^{a, b}		
	T _A = 70 °C		19.7 ^{a, b}		
Pulsed drain current (t = 100 μs)		I _{DM}	200	Α	
Continuous source-drain diode current	T _C = 25 °C		43.3		
	T _A = 25 °C	Is I	3.1 ^{a, b}		
Single pulse avalanche current	Ise avalanche current		20		
Single pulse avalanche energy	L = 0.1 mH	E _{AS}	20	mJ	
Maximum power dissipation	T _C = 25 °C		52		
	T _C = 70 °C	1 5 5	33	W	
	T _A = 25 °C	P _D	3.7 ^{a, b}	VV	
	T _A = 70 °C	1 -	2.4 ^{a, b}		
Operating junction and storage temperature range		T _J , T _{stq}	-55 to +150	°C	
Soldering recommendations (peak temperature) c, d			260	- °C	

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient a, e	t ≤ 10 s	R_{thJA}	24	33	°C/W	
Maximum junction-to-case (drain)	Steady state	R_{thJC}	1.9	2.4	C/VV	

Notes

- a. Surface mounted on 1" x 1" FR4 board
- b. t = 10 s
- c. See solder profile (www.vishay.com/doc?73257). The PowerPAK 1212-8S is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- d. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components
- e. Maximum under steady state conditions is 81 °C/W
- f. Based on T_C = 25 °C
- g. Package limited

Document Number: 62874



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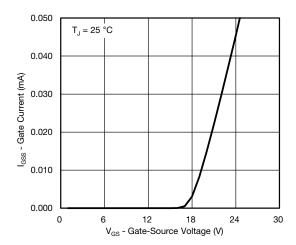
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static	<u>'</u>		I.	•			
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	20	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	-	-	18	-	mV/°C	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-3.5	-		
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 1 \text{ mA}$	0.5	-	1.2	V	
Gate-source leakage	I _{GSS} -	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$	-	-	± 10		
		$V_{DS} = 0 \text{ V}, V_{GS} = \pm 4.5 \text{ V}$	-	-	± 1	μΑ	
	_	V _{DS} = 20 V, V _{GS} = 0 V	-	-	1		
Zero gate voltage drain current	I _{DSS}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$	-	-	10		
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	20	-	-	Α	
Drain-source on-state resistance ^a	, ,	$V_{GS} = 4.5 \text{ V}, I_D = 14 \text{ A}$	-	0.0032	0.0039	1	
	R _{DS(on)}	$V_{GS} = 3.7 \text{ V}, I_D = 14 \text{ A}$	-	0.0035	0.0042	Ω	
	`	$V_{GS} = 2.5 \text{ V}, I_D = 13 \text{ A}$	-	0.0041	0.0058	1	
Forward transconductance a	9 _{fs}	$V_{DS} = 10 \text{ V}, I_D = 14 \text{ A}$	-	50	-	S	
Dynamic ^b	•		I.	•			
Input capacitance	C _{iss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	-	2060	-	pF	
Output capacitance	C _{oss}		-	558	-		
Reverse transfer capacitance	C _{rss}		-	365	-		
Tabel a standards a	0	$V_{DS} = 10 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	46	70	nC	
Total gate charge	Qg	V _{DS} = 10 V, V _{GS} = 4.5 V, I _D = 20 A	-	22.5	34		
Gate-source charge	Q_{gs}		-	4.1	-		
Gate-drain charge	Q_{gd}		-	5.3	-		
Gate resistance	R _q	f = 1 MHz	0.2	1	2	Ω	
Turn-on delay time	t _{d(on)}	V_{DD} = 10 V, R_L = 1 Ω $I_D \cong$ 10 A, V_{GEN} = 4.5 V, R_g = 1 Ω	-	16	24	-	
Rise time	t _r		-	65	98		
Turn-off delay time	t _{d(off)}		-	40	60		
Fall time	t _f		-	12	20		
Turn-on delay time	t _{d(on)}		-	9	18	ns	
Rise time	t _r	$V_{DD} = 10 \text{ V}, \text{ R}_L = 1 \Omega$ $I_D \cong 10 \text{ A}, \text{ V}_{GEN} = 10 \text{ V}, \text{ R}_g = 1 \Omega$	-	5	10		
Turn-off delay time	t _{d(off)}		-	34	51		
Fall time	t _f		-	4	8		
Drain-Source Body Diode Characteristic	cs						
Continuous source-drain diode current	I _S	T _C = 25 °C	-	-	50		
Pulse diode forward current (t = 100 μs)	I _{SM}		-	-	200	A	
Body diode voltage	V_{SD}	I _S = 10 A, V _{GS} = 0 V	-	0.75	1.2	V	
Body diode reverse recovery time	t _{rr}		-	22	44	ns	
Body diode reverse recovery charge	Q _{rr}		-	10	20	nC	
Reverse recovery fall time	t _a	$I_F = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$	-	11	-		
Reverse recovery rise time	t _b		-	11	_	ns	

Notes

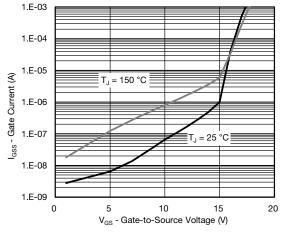
- a. Pulse test: pulse width \leq 300 μ s, duty cycle \leq 2 %
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

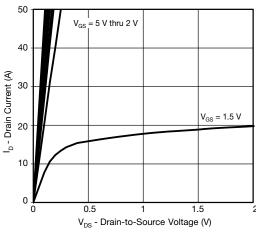




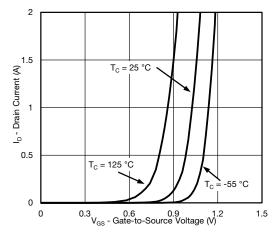
Gate Current vs. Gate-to-Source Voltage



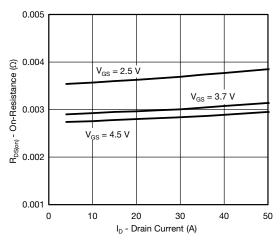
Gate Current vs. Gate-to-Source Voltage



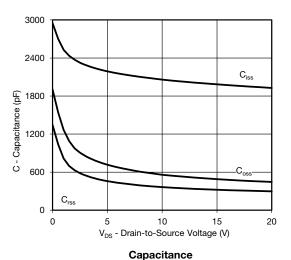
Output Characteristics



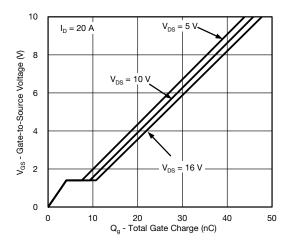
Transfer Characteristics



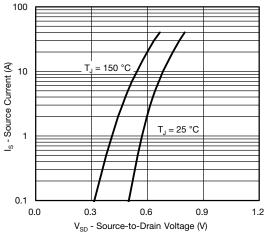
On-Resistance vs. Drain Current and Gate Voltage



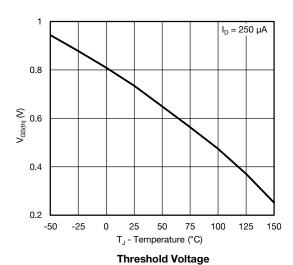


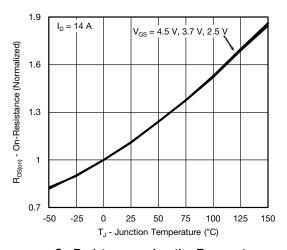


Gate Charge

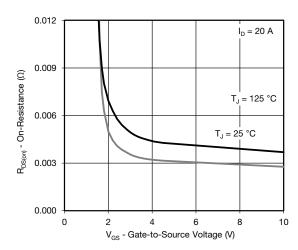


Source-Drain Diode Forward Voltage

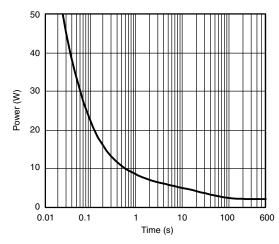




On-Resistance vs. Junction Temperature

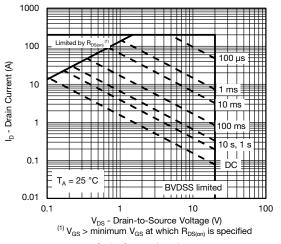


On-Resistance vs. Gate-to-Source Voltage

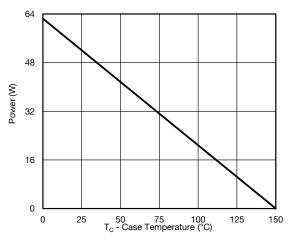


Single Pulse Power, Junction-to-Ambient

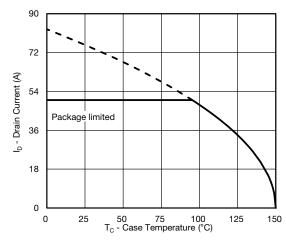




Safe Operating Area





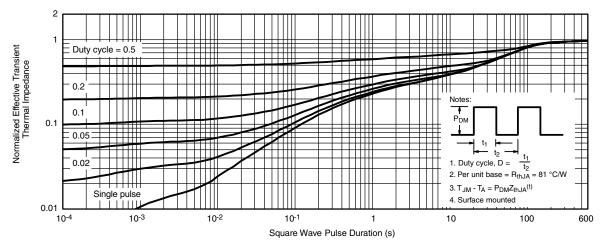


Current Derating a

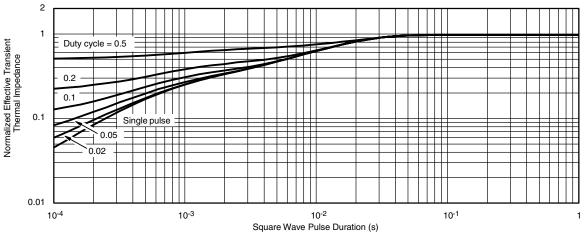
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package / tape drawings, part marking, and reliability data, see www.vishay.com/ppg?62874.



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